



Attorney Docket: 3319.3A (02US2)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: James W. Overbeck
Serial No: 10/034,620
Filed: December 27, 2001
For: WIDE FIELD OF VIEW AND HIGH SPEED SCANNING MICROSCOPY

Examiner: T.Q. Nguyen
Art Unit: 2872

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

RESPONSE

In Response to the Office Action dated September 17, 2004, Applicant amends this application as follows: